## Notice of References Cited Application/Control No. 10/748,691 Examiner OLUSEYE IWARERE Applicant(s)/Patent Under Reexamination SCHRODT ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0143669 A1	10-2002	Scheer, Robert H.	705/28
*	В	US-2002/0161674 A1	10-2002	Scheer, Robert H.	705/28
*	С	US-7,313,534 B2	12-2007	Scheer, Robert H.	705/9
*	D	US-6,249,774 B1	06-2001	Roden et al.	705/28
*	Е	US-6,640,214 B1	10-2003	Nambudiri et al.	705/26
*	F	US-7,240,027 B2	07-2007	McConnell et al.	705/28
*	G	US-2002/0065680 A1	05-2002	Kojima et al.	705/1
*	Η	US-6,151,582 A	11-2000	Huang et al.	705/8
*	I	US-2002/0174001 A1	11-2002	Henry, Dean	705/7
*	J	US-7,061,379 B2	06-2006	Chen et al.	340/572.1
*	К	US-6,853,303 B2	02-2005	Chen et al.	340/573.1
*	L	US-7,356,495 B2	04-2008	Beigl et al.	705/28
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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